

2SD0965 (2SD965)

Silicon NPN epitaxial planar type

For low-frequency power amplification

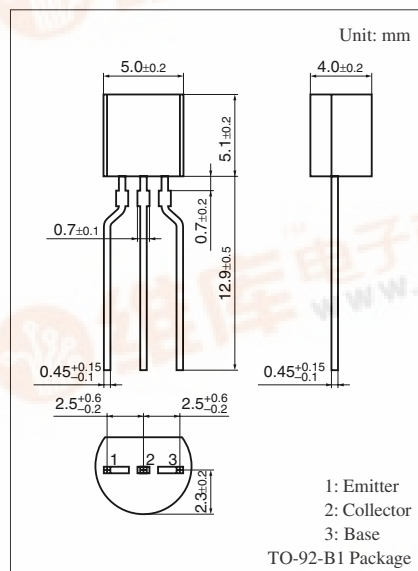
For stroboscope

■ Features

- Low collector-emitter saturation voltage $V_{CE(sat)}$
- Satisfactory operation performances at high efficiency with the low-voltage power supply.

■ Absolute Maximum Ratings $T_a = 25^\circ\text{C}$

Parameter	Symbol	Rating	Unit
Collector-base voltage (Emitter open)	V_{CBO}	40	V
Collector-emitter voltage (Base open)	V_{CEO}	20	V
Emitter-base voltage (Collector open)	V_{EBO}	7	V
Collector current	I_C	5	A
Peak collector current	I_{CP}	8	A
Collector power dissipation	P_C	750	mW
Junction temperature	T_j	150	$^\circ\text{C}$
Storage temperature	T_{stg}	-55 to $+150$	$^\circ\text{C}$



■ Electrical Characteristics $T_a = 25^\circ\text{C} \pm 3^\circ\text{C}$

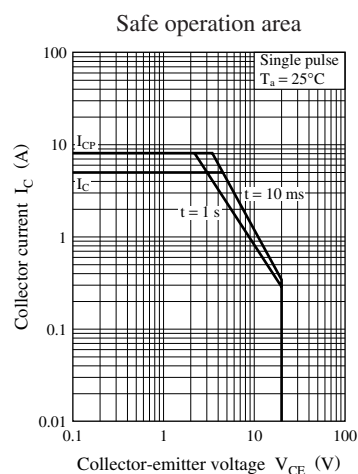
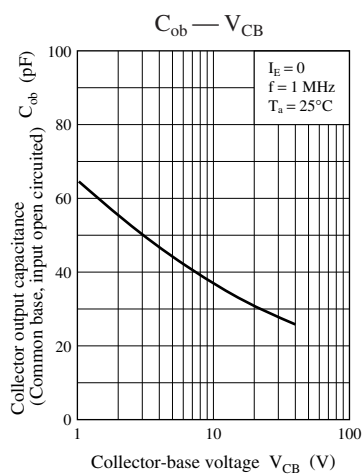
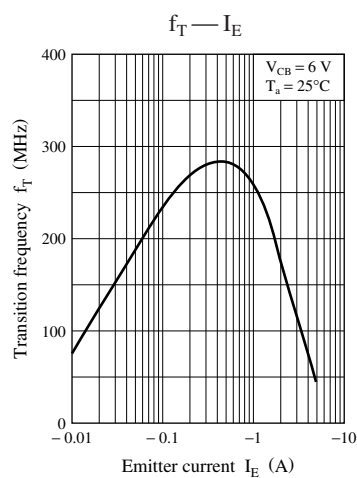
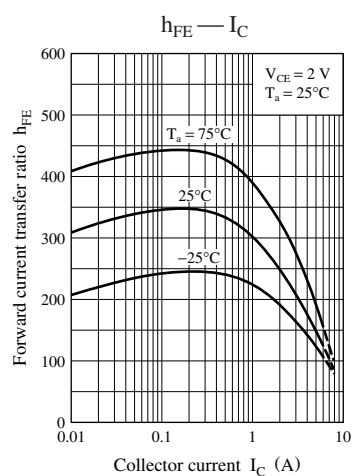
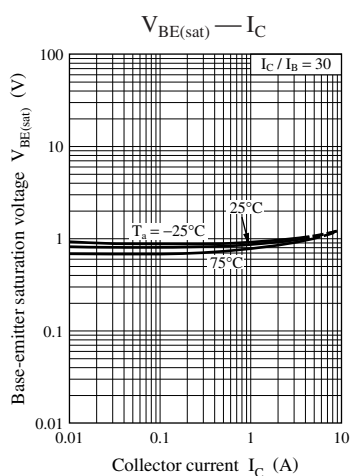
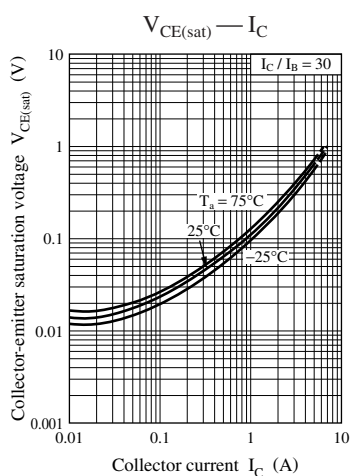
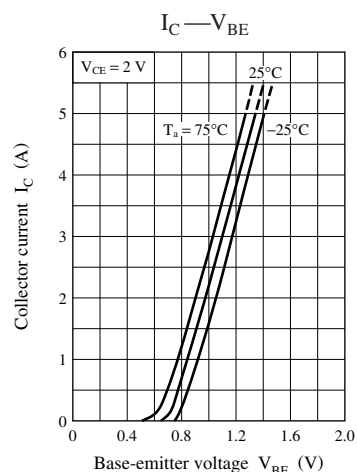
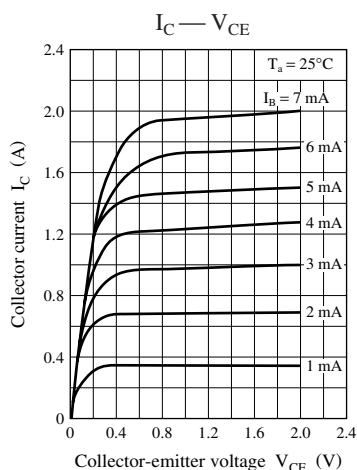
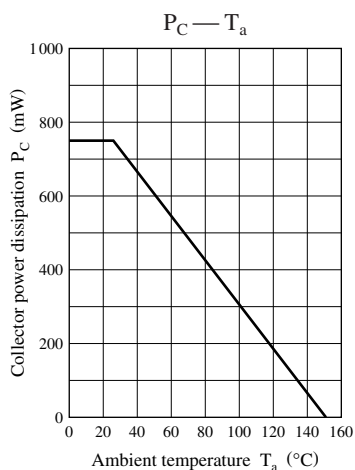
Parameter	Symbol	Conditions	Min	Typ	Max	Unit
Collector-emitter voltage (Base open)	V_{CEO}	$I_C = 1\text{ mA}$, $I_B = 0$	20			V
Emitter-base voltage (Collector open)	V_{EBO}	$I_E = 10\text{ }\mu\text{A}$, $I_C = 0$	7			V
Collector-base cutoff current (Emitter open)	I_{CBO}	$V_{CB} = 10\text{ V}$, $I_E = 0$			0.1	μA
Collector-emitter cutoff current (Base open)	I_{CEO}	$V_{CE} = 10\text{ V}$, $I_B = 0$			1	μA
Emitter-base cutoff current (Collector open)	I_{EBO}	$V_{EB} = 7\text{ V}$, $I_C = 0$			0.1	μA
Forward current transfer ratio	h_{FE1} *	$V_{CE} = 2\text{ V}$, $I_C = 0.5\text{ A}$	230		600	—
	h_{FE2}	$V_{CE} = 2\text{ V}$, $I_C = 1\text{ A}$	150			
Collector-emitter saturation voltage	$V_{CE(sat)}$	$I_C = 3\text{ A}$, $I_B = 0.1\text{ A}$		0.28	1.00	V
Transition frequency	f_T	$V_{CB} = 6\text{ V}$, $I_E = -50\text{ mA}$, $f = 200\text{ MHz}$		150		MHz
Collector output capacitance (Common base, input open circuited)	C_{ob}	$V_{CB} = 20\text{ V}$, $I_E = 0$, $f = 1\text{ MHz}$		26	50	pF

Note) 1. Measuring methods are based on JAPANESE INDUSTRIAL STANDARD JIS C 7030 measuring methods for transistors.

2. *: Rank classification

Rank	Q	R
h_{FE1}	230 to 380	340 to 600

Note) The part number in the parenthesis shows conventional part number.



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